

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/046,117	YARED ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Backhean Tiv	2151	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,853,843 A	08-1989	Ecklund, Denise J.	707/203
*	B	US-5,491,821 A	02-1996	Kilis, Danny	717/146
*	C	US-5,748,188 A	05-1998	Hu et al.	715/853
*	D	US-5,890,176 A	03-1999	Kish et al.	715/511
*	E	US-5,991,771 A	11-1999	Falls et al.	707/202
*	F	US-6,125,400 A	09-2000	Cohen et al.	709/247
*	G	US-6,199,198 B1	03-2001	Graham, Stephen	717/105
*	H	US-2002/0029375 A1	03-2002	Mlynarczyk et al.	717/108
*	I	US-2002/0116412 A1	08-2002	Barnes et al.	707/513
*	J	US-2002/0188950 A1	12-2002	Soloff et al.	725/63
*	K	US-2003/0123537 A1	07-2003	Yona et al.	375/240.01
*	L	US-6,141,792	10-2000	Acker et al.	717/116
*	M	US-6,721,942 B1	04-2004	Sievert, James A.	717/137

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.